

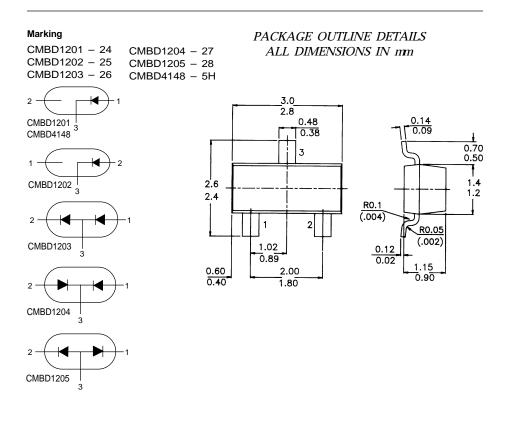


SOT-23 Formed SMD Package

CMBD1201, CMBD1202, CMBD1203 CMBD1204, CMBD1205, CMBD4148

# SILICON PLANAR EPITAXIAL HIGH SPEED DIODES

CMBD1201, 1202, CMBD4148 are all single diodes CMBD1203 is a dual diode, in series CMBD1204 is a dual diode, common cathode CMBD1205 is a dual diode, common anode



#### ABSOLUTE MAXIMUM RATINGS (per diode)

Continuous reverse voltage	$V_R$	max.	75 V
Repetitive peak reverse voltage	V <sub>RRM</sub>	max.	100 V
Repetitive peak forward current	I <sub>FRM</sub>	max.	500 mA
Forward current	$I_F$	max.	215 mA
Junction temperature	$T_{j}$	max.	150 °C
Forward voltage at $I_F = 10 \text{ mA}$	$\check{V}_F$	<	0.855 V

### CMBD1201, CMBD1202, CMBD1203 CMBD1204, CMBD1205, CMBD4148

Reverse recovery time when switched from						
$I_F = 10 \text{ mA}$ to $I_R = 10 \text{ mA}$ ; $R_L = 100 \Omega$ ;						
measured at $I_R = 1 mA$	t <sub>rr</sub>	<	4 ns			
<b>RATINGS</b> (per diode) (at $T_A = 25^{\circ}C$ unless otherwise specified)						
Limiting values	-					
Continuous reverse voltage	$V_R$	max.	75 V			
Repetitive peak reverse voltage	V <sub>RRM</sub>	max.	100 V			
Repetitive peak forward current	I <sub>FRM</sub>	max.	500 mA			
Forward current	$I_F$	max.	215 mA			
Non-repetitive peak forward current (per crystal)						
$t = 1 \ \mu s$	IFSM	max.	4 A			
t = 1 ms	IFSM	max.	1.0 A			
t = 1 s	IFSM	max.	0.5 A			
Storage temperature	Tstg	–55 ta	o +150 °C			
Junction temperature	Tj	max.	150 °C			
THERMAL RESISTANCE						
From junction to ambient	R <sub>th j-a</sub>	=	500 K/W			
	5					
CHARACTERISTICS (per diode)						
$T_i = 25$ °C unless otherwise specified						
Forward voltage						
$I_F = 10 mA$	$V_F$	<	0.855 V			
$I_F = 200 mA$	$V_F$	<	1.05 V			
$I_F = 10 mA$ CMBD4148	$V_F$	<	1.0 V			
Reverse currents						
$V_R = 20 V$	$I_R$	<	25 nA			
$V_R = 75 V$	$I_R$	<	$5 \mu A$			
$V_R = 25 \; V; \; T_j = 150 \; ^{\circ}C$	$I_R$	<	30 µA			
Forward recovery voltage						
$I_F = 10 mA; t_p = 20 ns$	Vfr	<	1.75 V			
Recovery charge						
$I_F = 10 \text{ mA}$ to $V_R = 5V$ ; $R = 100 \Omega$	$Q_{S}$	<	45 pC			
Diode capacitance						
$V_R = 0; f = 1 MHz$	$C_d$	<	2 pF			
Reverse recovery time when switched from						
$I_F = 10 \text{ mA}$ to $I_R = 10 \text{ mA}$ ; $R_L = 100 \Omega$ ;						
measured at $I_R = 1 mA$	t <sub>rr</sub>	<	4 ns			

### **Customer Notes**

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## Disclaimer

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